

XPS Analysis Request Form

Never Stand Still	Mark Wainwright Analytical	Centre	Solid State and E	Elemental Analysis Unit
Date		Company/Organisation		
Analysis requested by		Supervisor's Name		
Contact Phone		Supervisor's Phone		
Contact Email		Supervisor's Email		
*			*	
Billing Address		F	PO number	
Sample names and Descript	tion (detailed info should be a	ttached s	separately):	
1		7		
2		8		
3		9		
4		10		
5		11		
6		12		
Form of samples	☐ Thin film ☐ So	olid bulk	☐ Powder	□ Fiber
Do you want the sample ret	urned?	Yes	□ No	
Standard XPS Analysis				
	y Scan • Region scans	• Curv	ve fitting and quantit	iication
☐ Original surface	, coan riogion coanc	.		
☐ Ion beam cleaned surface	e □30s (default)	□60s	□120s	
☐ Any elements specifically concerned (other than C and O)				
Standard UPS Analysis	Survey • Fermi Edge			
☐ Original surface	Julyey • Fermi Luge			
☐ Ion beam cleaned surface	ee □30s (default)	□60s	□120s	
<u>Depth Profile</u> (Thin film and E	Bulk sample only)			
· ·	tsrs of or th			nanometers
through the layers of				
□ Layered structure of your sample				
<u>Further comments</u> : (eg. Special instructions, priority, importance, required by date, etc)				
□ Special booking				
	PLEASE COLLECT THEM WITHIN mence unless the PO number			TS.

Post Address: Mark Wainwright Analytical Centre, Room G61, June Griffith Building (F10), UNSW, NSW 2052, Australia